Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/698,622	JONG ET AL.
Examiner	Art Unit
Emmanuel Bayard	2638

	SEAR	CHED	
Class	Subclass	Date	Examiner
37	207	12/31/05	0-13
7	228		Δ
	355		
U	372		
37	375		
327	57		
ĵ.	74		
<i>V</i>	25	V	
327	76	12/37/05	à s
		' /	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	ŀ				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
œAsí		12/31/2	C'G	
		·		